

<b>Notice of References Cited</b>	Application/Control No. 10/691,637		Applicant(s)/Patent Under Reexamination TOKUDA ET AL.	
	Examiner David S. Baker		Art Unit 2884	Page 1 of 1

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*	B	US-5,693,947 A	12-1997	Morton, Edward J.	250/370.09
*	C	US-6,420,710 B1	07-2002	Verger et al.	250/370.06
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	K	US-			
	L	US-			
	M	US-			

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	N	WO 200068999 A1	11-2000	World Intellect	BONNET et al.	
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**NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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